



Vishay Siliconix

N-Channel 20-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$r_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ)		
20	0.0033 at V _{GS} = 10 V	40	30 nC		
20	0.0044 at $V_{GS} = 4.5 \text{ V}$	40	30 110		

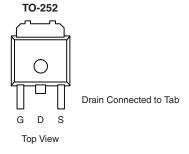
FEATURES

- TrenchFET® Power MOSFET
- 100 % R_g Tested

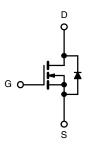


APPLICATIONS

Server



Order Number: SUD40N02-3m3P-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S T _A = 25 °C, unles	s otherwise no	oted		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage	V _{GS}	± 20			
	T _C = 25 °C		40 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 100 °C	- I _D	40 ^a		
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C		24.4 ^b		
	T _A = 100 °C		17.2 ^b	Α	
Pulsed Drain Current		I _{DM}	100		
Continuous Source-Drain Diode Current	T _C = 25 °C	- I _S	40 ^a		
	T _A = 25 °C		2.8 ^b		
	T _C = 25 °C		79		
Maximum Power Dissipation	T _C = 100 °C		39.5	W	
Maximum Power Dissipation	T _A = 25 °C	P_{D}	3.3 ^b	_ vv	
	T _A = 100 °C		1.6 ^b		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	37	45	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.5	1.9	C/VV	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

SUD40N02-3m3P

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SPECIFICATIONS $T_J = 25 ^{\circ}\text{C}$	Symbol	Test Conditions	Min.	Typ.	Max.	Unit		
Static		1000 00000000		.,,,,				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			21				
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.9		mV/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA		
<u> </u>		V _{DS} = 20 V, V _{GS} = 0 V			1			
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 100 °C			20	μΑ		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α		
	D(OII)	V _{GS} = 10 V, I _D = 20 A		0.0027	0.0033	 		
Drain-Source On-State Resistance ^a	r _{DS(on)}	V _{GS} = 4.5 V, I _D = 20 A		0.0036	0.0044	_ Ω		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		100		S		
Dynamic ^b		50 5		1		<u>I</u>		
Input Capacitance	C _{iss}			6520		pF		
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		1430				
Reverse Transfer Capacitance	C _{rss}			770				
Total Gate Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 50 \text{ A}$		105	160			
	Qg			50	75			
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 50 \text{ A}$		17				
Gate-Drain Charge	Q _{qd}			14				
Gate Resistance	R _q	f = 1 MHz		1.2	1.9	Ω		
Turn-On Delay Time	t _{d(on)}			40	60			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 0.2 \Omega$		30	45			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 50 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		67	101			
Fall Time	t _f			33	50	ns		
Turn-On Delay Time	t _{d(on)}			13	20			
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_1 = 0.2 \Omega$		7	11			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		40	60			
Fall Time	t _f			9	14			
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			40	Δ.		
Pulse Diode Forward Current ^a	I _{SM}				100	A		
Body Diode Voltage	V _{SD}	I _S = 20 A		0.81	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			38	57	ns		
Body Diode Reverse Recovery Charge				34	51	nC		
Reverse Recovery Fall Time	ta	$I_F = 50 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		18		ns		
Reverse Recovery Rise Time	t _b			20				

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

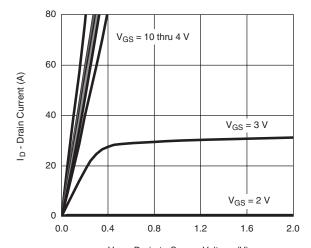
b. Guaranteed by design, not subject to production testing.



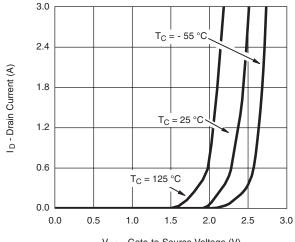


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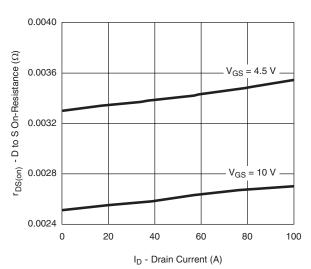
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



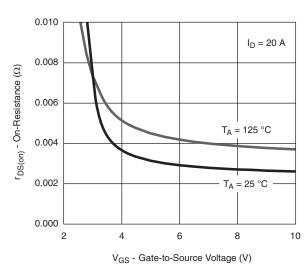
V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics**



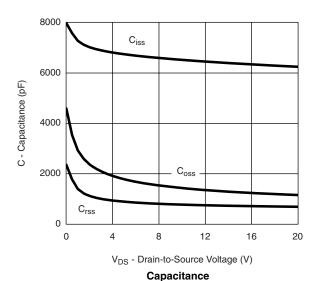
V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**



On-Resistance vs. Drain Current



On-Resistance vs. V_{GS} vs. Temperature



I_D = 50 A $V_{DS} = 10 \text{ V}$ V_{GS} - Gate-to-Source Voltage (V) 8 6 V_{DS} = 16 V 2 0 20 40 100 0 120

10

Q_g - Total Gate Charge (nC)

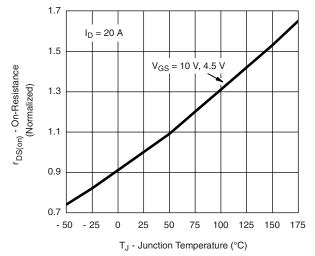
Gate Charge

SUD40N02-3m3P

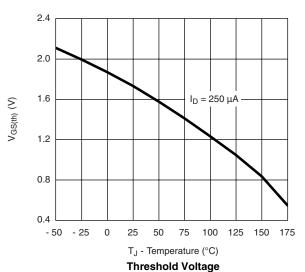
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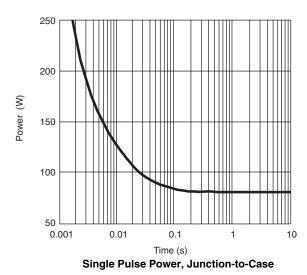
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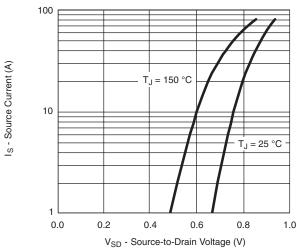
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



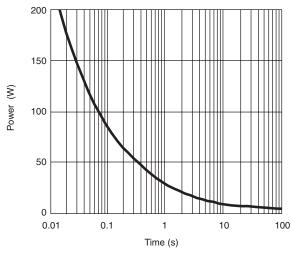
On-Resistance vs. Junction Temperature



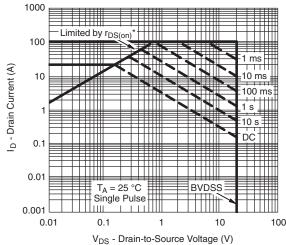




Forward Diode Voltage vs. Temperature



Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which r_{DS(on)} is specified

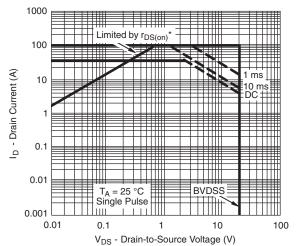
Safe Operating Area, Junction-to-Ambient





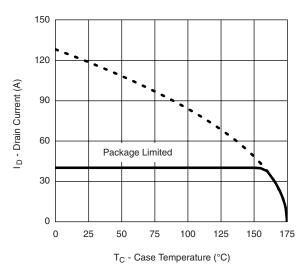
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

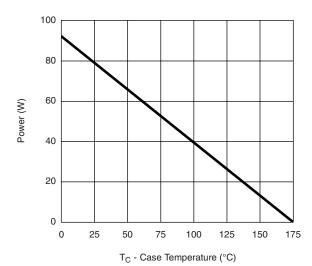


 * V $_{GS}$ > minimum V $_{GS}$ at which r $_{DS(on)}$ is specified

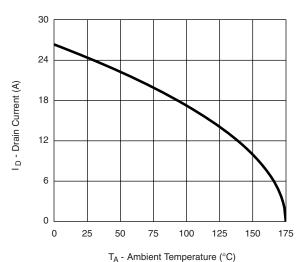
Safe Operating Area, Junction-to-Case



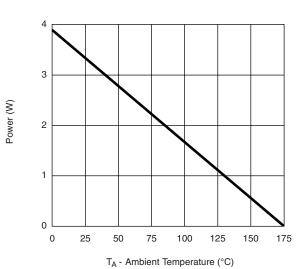
Current Derating**, Junction-to-Case



Power Derating**, Junction-to-Case



Current Derating**, Junction-to-Ambient



Power Derating**, Junction-to-Ambient

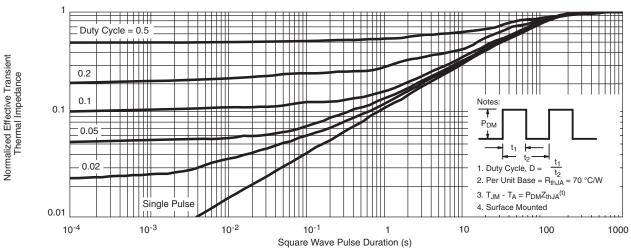
^{**} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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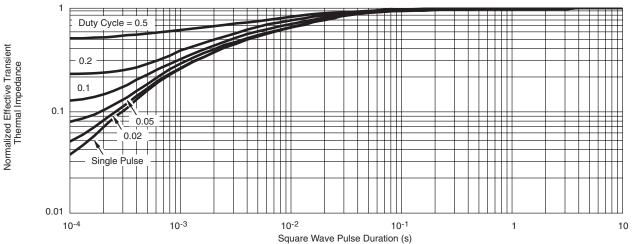
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



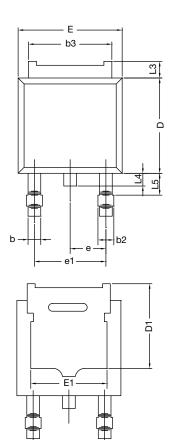
Normalized Thermal Transient Impedance, Junction-to-Case

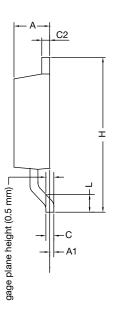
Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?69819.





TO-252AA Case Outline



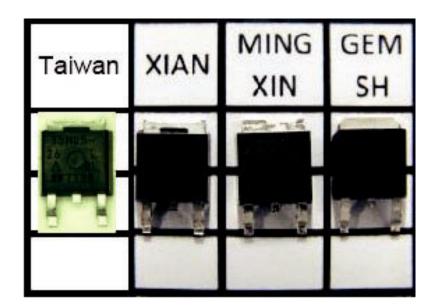


	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECN: T13-0359-Rev. O, 03-Jun-13					

DWG: 5347

Notes

- Dimension L3 is for reference only.
- Xi'an, Mingxin, and GEM SH actual photo.



Revision: 03-Jun-13 Document Number: 71197



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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